


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510328	<b>Applicant(s)/Patent Under Reexamination</b>  CICHUTEK ET AL.
	<b>Examiner</b>  MARIA B MARVICH	<b>Art Unit</b>  1633

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN, East search updated, search notes attached	7/28/08	MM
search updated, search notes attached	1/7/10	MM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
na		1/7/10	MM

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